DATA SHEET

74ALVCH162601

18-bit universal bus transceiver with 30 Ω termination resistor; 3-state

Product specification

File under Integrated Circuits, IC24

1999 Oct 14

18-bit universal bus transceiver with 30 Ω termination resistor; 3-state

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FEATURES

• Complies with JEDEC standard no. 8-1A

• CMOS low power consumption

• Direct interface with TTL levels

• MULTIBYTE™ flow-through standard pin-out architecture

• Low inductance multiple V_{CC} and ground pins for minimum noise and ground bounce

• All data inputs have bus hold circuitry

• Integrated 30 Ω termination resistors.

DESCRIPTION

The 74ALVCH162601 is an 18-bit universal transceiver featuring non-inverting 3-state bus compatible outputs in both send and receive directions. Data flow in each direction is controlled by output enable ($\overline{OE}_{AB}$ and $\overline{OE}_{BA}$), and clock (CP_{AB} and CP_{BA}) inputs. For A-to-B data flow, the device operates in the transparent mode when LE_{AB} is HIGH. When LE_{AB} is LOW, the A data is latched if CP_{AB} is held at a HIGH or LOW logic level. If LE_{AB} is LOW, the A-bus data is stored in the latch/flip-flop on the LOW-to-HIGH transition of CP_{AB}. When $\overline{OE}_{AB}$ is LOW, the outputs are active. When $\overline{OE}_{AB}$ is HIGH, the outputs are in the high-impedance state. The clocks can be controlled with the clock-enable inputs ($\overline{CE}_{BA}/\overline{CE}_{AB}$).

Data flow for B-to-A is similar to that of A-to-B but uses $\overline{OE}_{BA}$, LE_{BA} and CP_{BA}.

To ensure the high-impedance state during power-down, $\overline{OE}_{BA}$ and $\overline{OE}_{AB}$ should be tied to V_{CC} through a pull-up resistor, the minimum value of the resistor is determined by the current-sinking/current-sourcing capability of the driver.

The 74ALVCH162601 is designed with 30 Ω series resistors in both HIGH or LOW output stage.

Active bus hold circuitry is provided to hold unused or floating data inputs at a valid logic level.

QUICK REFERENCE DATA

Ground = 0; T_{amb} = 25 °C; t_r = t_f = 2.5 ns.

SYMBOL	PARAMETER	CONDITIONS	TYPICAL	UNIT
t_{PHL}/t_{PLH}	propagation delay A_n, B_n to B_n, A_n	C_L = 30 pF; V_{CC} = 2.5 V	4.0	ns
		C_L = 50 pF; V_{CC} = 3.3 V	3.1	ns
$C_{I/O}$	input/output capacitance		8.0	pF
C_I	input capacitance		4.0	pF
C_{PD}	power dissipation capacitance per latch	notes 1 and 2		
		outputs enabled	21	pF
		outputs disabled	3	pF

Notes

1. C_{PD} is used to determine the dynamic power dissipation (P_D in µW).

   $P_D = C_{PD} \times V_{CC}^2 \times f_i + \Sigma (C_L \times V_{CC}^2 \times f_o)$ where:

   f_i = input frequency in MHz;

   f_o = output frequency in MHz;

   $\Sigma (C_L \times V_{CC}^2 \times f_o)$ = sum of outputs;

   C_L = output load capacitance in pF;

   V_{CC} = supply voltage in Volts.

2. The condition is V_I = GND to V_{CC}.

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FUNCTION TABLE

See note 1.

INPUTS					OUTPUTS	STATUS
$\overline{CE}_{XX}$	$\overline{OE}_{XX}$	LE_{XX}	CP_{XX}	A_n, B_n		
X	H	X	X	X	Z	disabled
X	L	H	X	H	H	transparent
X	L	H	X	L	L	
H	L	L	X	X	NC	hold
L	L	L	↑	h	H	clock and display
L	L	L	↑	l	L	
L	L	L	L	X	NC	hold
L	L	L	H	X		

Note

1. XX = AB for A-to-B direction, BA for B-to-A direction;

    H = HIGH voltage level;

    L = LOW voltage level;

    h = HIGH state must be present one set-up time before the LOW-to-HIGH transition of CP_{XX};

    l = LOW state must be present one set-up time before the LOW-to-HIGH transition of CP_{XX};

    X = don't care;

    ↑ = LOW-to-HIGH level transition;

    NC = no change;

    Z = high-impedance OFF-state.

ORDERING INFORMATION

TYPE NUMBER	PACKAGE				
	TEMPERATURE RANGE	PINS	PACKAGE	MATERIAL	CODE
74ALVCH162601DGG	−40 to +85 °C	56	TSSOP	plastic	SOT364-1

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PINNING

PIN	SYMBOL	DESCRIPTION
1	$\overline{OE}_{AB}$	output enable A-to-B
2	LE_{AB}	latch enable A-to-B
3, 5, 6, 8, 9, 10, 12, 13, 14, 15, 16, 17, 19, 20, 21, 23, 24, 26	A_0 to A_{17}	data inputs/outputs
4, 11, 18, 25, 32, 39, 46, 53	GND	ground (0 V)
7, 22, 35, 50	V_{CC}	DC supply voltage
27	$\overline{OE}_{BA}$	output enable B-to-A
28	LE_{BA}	latch enable B-to-A
29	$\overline{CE}_{BA}$	clock enable B-to-A
30	CP_{BA}	clock input B-to-A
31, 33, 34, 36, 37, 38, 40, 41, 42, 43, 44, 45, 47, 48, 49, 51, 52, 54	B_{17} to B_0	data inputs/outputs
55	CP_{AB}	clock input A-to-B
56	$\overline{CE}_{AB}$	clock enable A-to-B

18-bit universal bus transceiver with 30 Ω termination resistor; 3-state
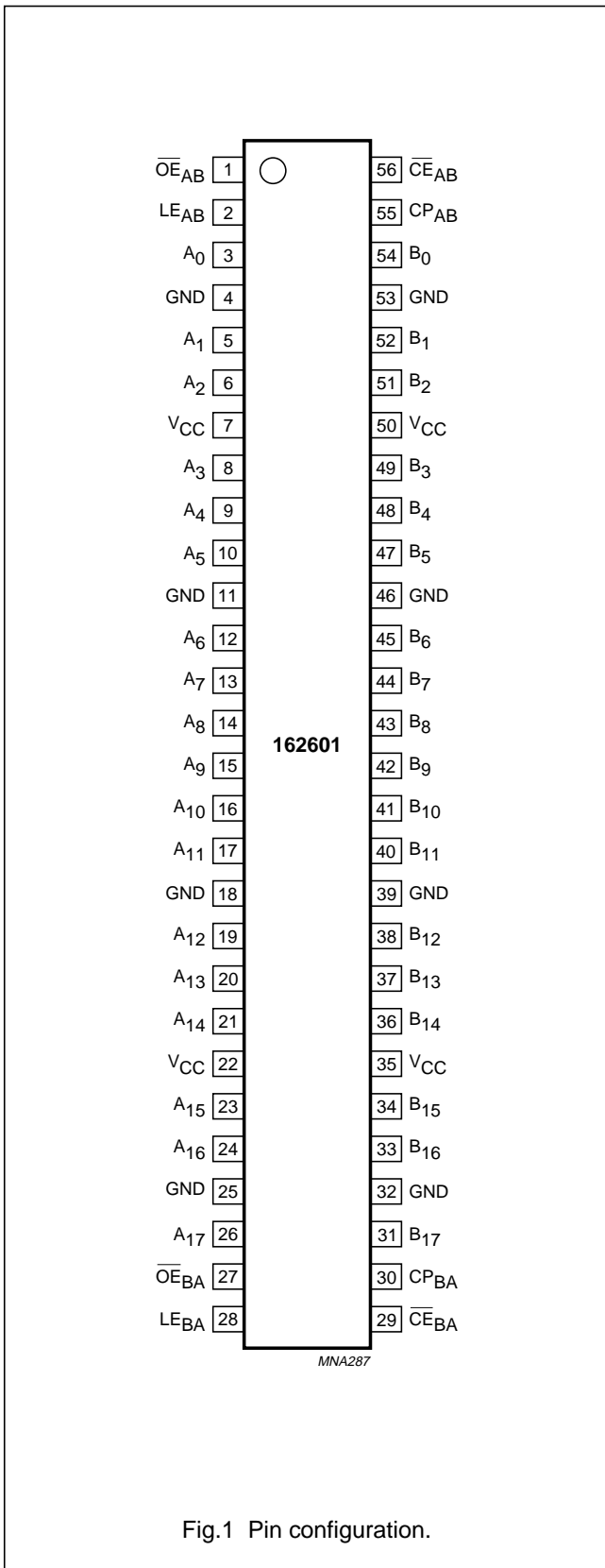
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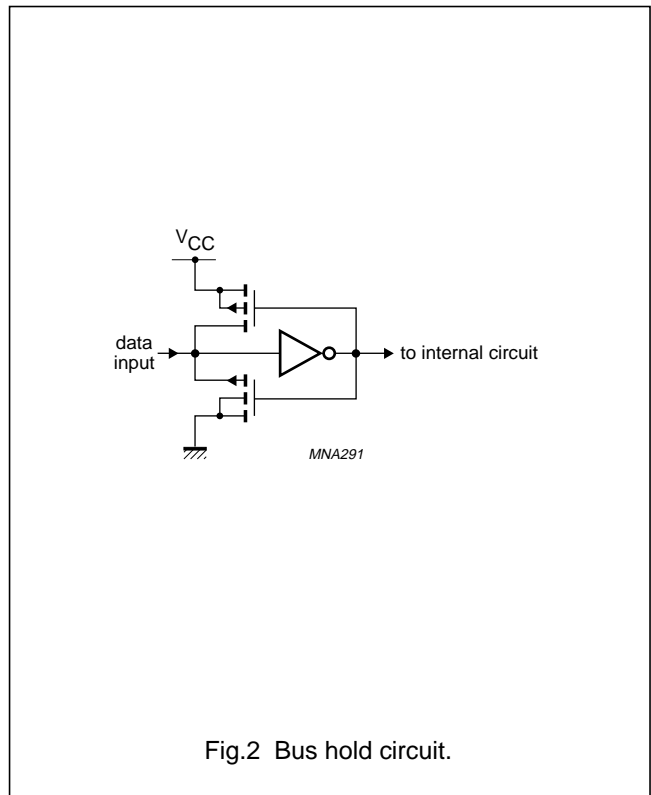

Fig.1 Pin configuration.

Fig.2 Bus hold circuit.

18-bit universal bus transceiver with 30 Ω
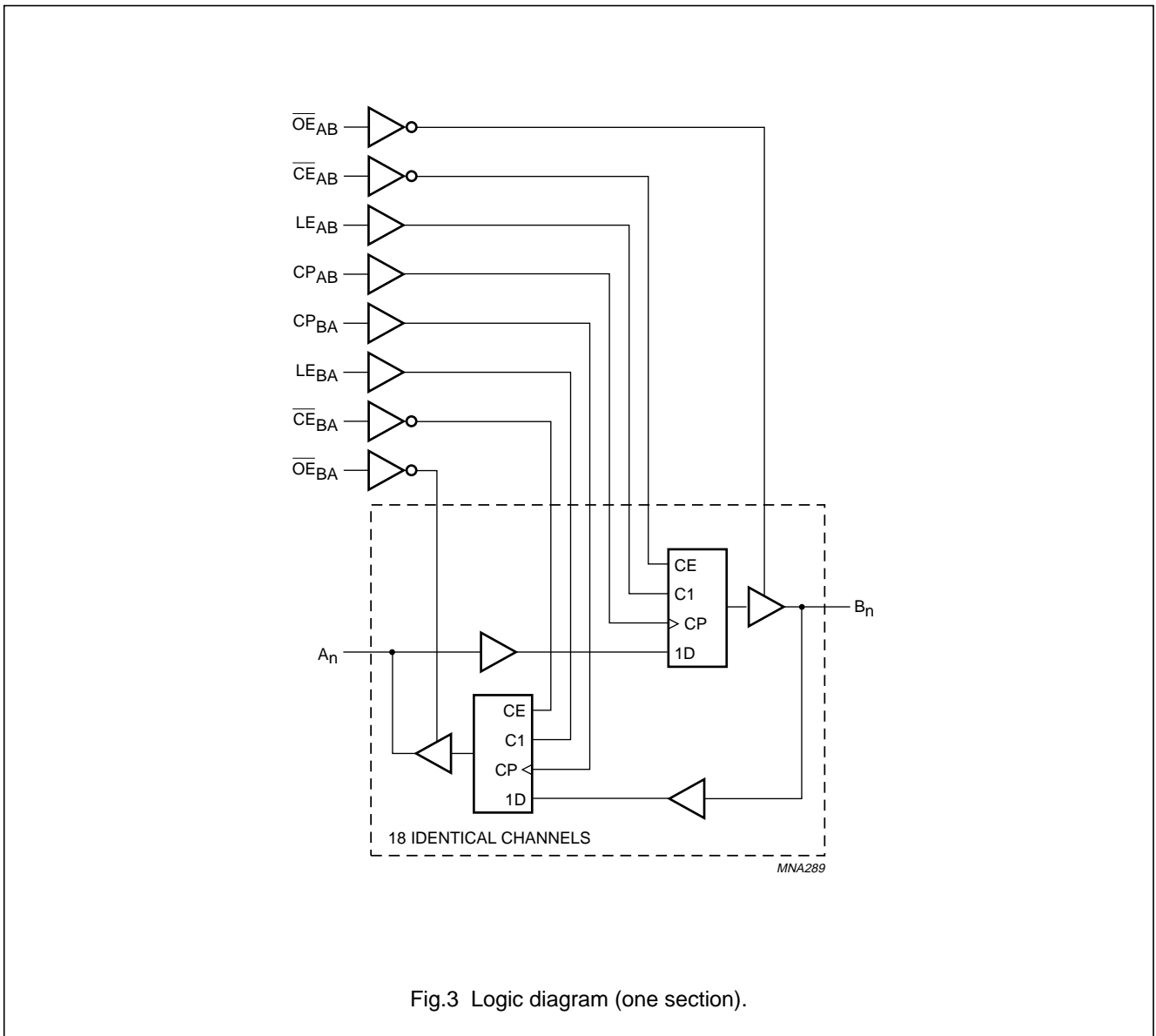termination resistor; 3-state

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Fig.3 Logic diagram (one section).

18-bit universal bus transceiver with 30 Ω
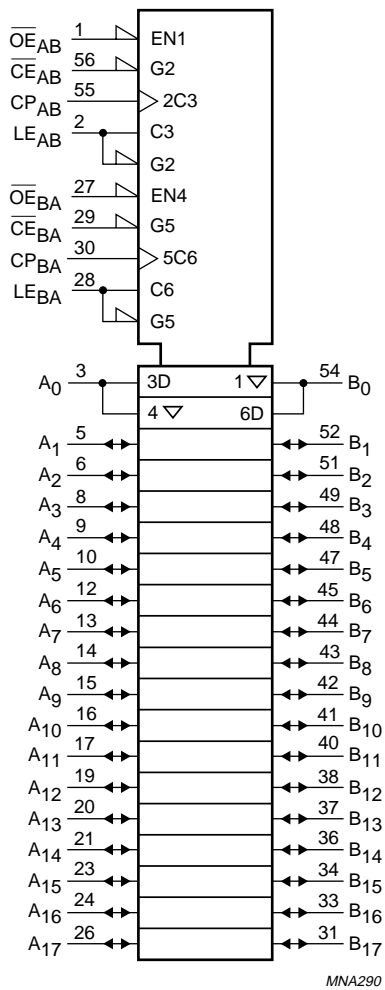termination resistor; 3-state
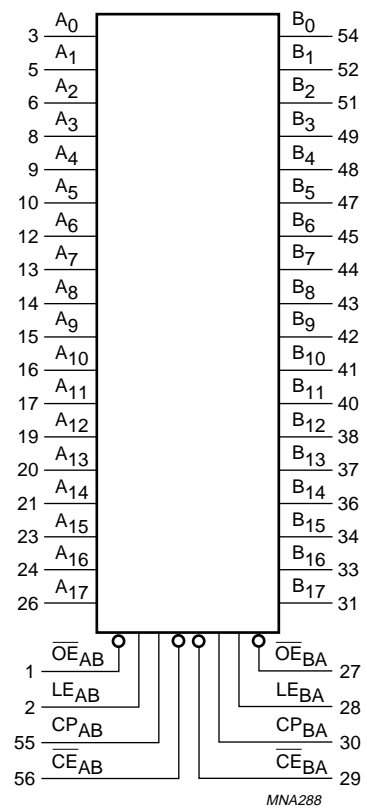
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Fig.4 IEC logic symbol.

Fig.5 Logic symbol.

RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V_{CC}	DC supply voltage					
	for max. speed performance	C_L = 30 pF	2.3	2.5	2.7	V
	for max. speed performance	C_L = 50 pF	3.0	3.3	3.6	V
	for low-voltage applications		1.2	2.4	3.6	V
V_I	DC input voltage		0	–	V_{CC}	V
V_O	DC output voltage		0	–	V_{CC}	V
T_{amb}	operating ambient temperature	in free air	–40	–	+85	°C
t_r, t_f	input rise and fall times	V_{CC} = 2.3 to 3.0 V	0	–	20	ns/V
		V_{CC} = 3.0 to 3.6 V	0	–	10	ns/V

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134); voltages are referenced to GND (ground = 0 V).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V_{CC}	DC supply voltage		–0.5	+4.6	V
I_{IK}	DC input diode current	V_I < 0	–	–50	mA
V_I	DC input voltage	note 1	–0.5	+4.6	V
I_{OK}	DC output diode current	V_O > V_{CC} or V_O < 0	–	±50	mA
V_O	DC output voltage	note 1	–0.5	V_{CC} + 0.5	V
I_O	DC output source or sink current	V_O = 0 to V_{CC}	–	±50	mA
I_{CC}, I_{GND}	DC V_{CC} or GND current		–	±100	mA
T_{stg}	storage temperature		–65	+150	°C
P_{tot}	power dissipation	for temperature range: –40 to +125 °C; note 2	–	600	mW

Notes

1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

2. Above 55 °C the value of P_{tot} derates linearly with 8 mW/K.

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DC CHARACTERISTICS

Over recommended operating conditions; voltages are referenced to GND (ground = 0 V).

SYMBOL	PARAMETER	TEST CONDITIONS			T_{amb} = −40 TO +85 °C			UNIT
		V_I (V)	OTHER	V_{CC} (V)	MIN.	TYP.[1]	MAX.	
V_{IH}	HIGH-level input voltage			2.3 to 2.7	1.7	1.2	–	V
				2.7 to 3.6	2.0	1.5	–	
V_{IL}	LOW-level input voltage			2.3 to 2.7	–	1.2	0.7	V
				2.7 to 3.6	–	1.5	0.8	
V_{OH}	HIGH-level output voltage	V_{IH} or V_{IL}	I_O = −100 μA	2.3 to 3.6	V_{CC} − 0.2	V_{CC}	–	V
			I_O = −4 mA	2.3	V_{CC} − 0.4	V_{CC} − 0.11	–	
			I_O = −6 mA	2.3	V_{CC} − 0.6	V_{CC} − 0.17	–	
			I_O = −4 mA	2.7	V_{CC} − 0.5	V_{CC} − 0.09	–	
			I_O = −8 mA	2.7	V_{CC} − 0.7	V_{CC} − 0.19	–	
			I_O = −6 mA	3.0	V_{CC} − 0.6	V_{CC} − 0.13	–	
			I_O = −12 mA	3.0	V_{CC} − 1.0	V_{CC} − 0.27	–	
V_{OL}	LOW-level output voltage	V_{IH} or V_{IL}	I_O = 100 μA	2.3 to 3.6	–	GND	0.20	V
			I_O = 4 mA	2.3	–	0.07	0.40	
			I_O = 6 mA	2.3	–	0.11	0.55	
			I_O = 4 mA	2.7	–	0.06	0.40	
			I_O = 8 mA	2.7	–	0.13	0.60	
			I_O = 6 mA	3.0	–	0.09	0.55	
			I_O = 12 mA	3.0	–	0.19	0.80	
I_I	input leakage current	V_{CC} or GND		2.3 to 3.6	–	0.1	5	μA
I_{OZ}	3-state output OFF-state current	V_{IH} or V_{IL}	V_O = V_{CC} or GND	2.3 to 3.6	–	0.1	10	μA
I_{CC}	quiescent supply voltage	V_{CC} or GND	I_O = 0	2.3 to 3.6	–	0.2	40	μA
ΔI_{CC}	additional quiescent supply current given per data I/O pin with bus hold	V_{CC} − 0.6	I_O = 0	2.3 to 3.6	–	150	750	μA
I_{BHL}	bus hold LOW sustaining current	0.7[2]		2.3[2]	45	–	–	μA
		0.8[2]		3.0[2]	75	150	–	
I_{BHH}	bus hold HIGH sustaining current	1.7[2]		2.3[2]	−45		–	μA
		2.0[2]		3.0[2]	−75	−175	–	
I_{BHLO}	bus hold LOW overdrive current			3.6[2]	500	–	–	μA
I_{BHHO}	bus hold LOW overdrive current			3.6[2]	−500	–	–	μA

Notes

1. All typical values are measured at T_{amb} = 25 °C.

2. Valid for data inputs of bus hold parts.

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AC CHARACTERISTICS FOR V$_{CC}$ = 2.3 TO 2.7 V

Ground = 0 V; t$_r$ = t$_f$ $\leq$ 2.0 ns; C$_L$ = 30 pF.

SYMBOL	PARAMETER	TEST CONDITIONS		T$_{amb}$ = −40 TO +85 °C			UNIT
		WAVEFORMS	V$_{CC}$ (V)	MIN.	TYP.[1]	MAX.	
t$_{PHL}$/t$_{PLH}$	propagation delay A$_n$, B$_n$ to B$_n$, A$_n$	see Figs 6 and 10	2.3 to 2.7	1.3	4.0	5.3	ns
	propagation delay LE$_{AB}$, LE$_{BA}$ to B$_n$, A$_n$	see Figs 7 and 10	2.3 to 2.7	1.0	4.5	6.0	ns
	propagation delay CP$_{AB}$, CP$_{BA}$ to B$_n$, A$_n$	see Figs 7 and 10	2.3 to 2.7	1.5	4.7	6.4	ns
t$_{PZH}$/t$_{PZL}$	3-state output enable time $\overline{OE}_{AB}$, $\overline{OE}_{BA}$ to B$_n$, A$_n$	see Figs 8 and 10	2.3 to 2.7	1.6	3.9	6.1	ns
t$_{PHZ}$/t$_{PLZ}$	3-state output disable time $\overline{OE}_{AB}$, $\overline{OE}_{BA}$ to B$_n$, A$_n$	see Figs 8 and 10	2.3 to 2.7	1.8	2.6	5.7	ns
t$_W$	clock pulse width HIGH LE$_{AB}$ or LE$_{BA}$	see Figs 7 and 10	2.3 to 2.7	3.3	1.6	−	ns
	clock pulse width HIGH or LOW CP$_{AB}$ or CP$_{BA}$	see Figs 7 and 10	2.3 to 2.7	3.3	2.0	−	ns
t$_{su}$	set-up time A$_n$, B$_n$ to CP$_{AB}$, CP$_{BA}$	see Figs 9 and 10	2.3 to 2.7	+2.3	−0.2	−	ns
	set-up time A$_n$, B$_n$ to LE$_{AB}$, LE$_{BA}$	see Figs 9 and 10	2.3 to 2.7	1.3	0.1	−	ns
	set-up time $\overline{CE}_{AB}$, $\overline{CE}_{BA}$ to CP$_{AB}$, CP$_{BA}$		2.3 to 2.7	+2.0	−0.4	−	ns
t$_h$	hold time A$_n$, B$_n$ to CP$_{AB}$, CP$_{BA}$	see Figs 9 and 10	2.3 to 2.7	1.2	0.3	−	ns
	hold time A$_n$, B$_n$ to LE$_{AB}$, LE$_{BA}$	see Figs 9 and 10	2.3 to 2.7	1.3	0.2	−	ns
	hold time $\overline{CE}_{AB}$, $\overline{CE}_{BA}$ to CP$_{AB}$, CP$_{BA}$		2.3 to 2.7	1.1	0.4	−	ns
f$_{max}$	maximum clock pulse frequency	see Figs 7 and 10	2.3 to 2.7	150	190	−	MHz

Note

1. All typical values are measured at T$_{amb}$ = 25 °C and V$_{CC}$ = 2.5 V.

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AC CHARACTERISTICS FOR V_{CC} = 2.7 V AND V_{CC} = 3.0 TO 3.6 V

Ground = 0 V; $t_r = t_f \leq 2.5$ ns; C_L = 50 pF.

SYMBOL	PARAMETER	TEST CONDITIONS		T_{amb} = −40 TO +85 °C			UNIT
		WAVEFORMS	V_{CC} (V)	MIN.	TYP.[1]	MAX.	
t_{PHL}/t_{PLH}	propagation delay A_n, B_n to B_n, A_n	see Figs 6 and 10	2.7	–	3.9	5.2	ns
			3.0 to 3.6	1.6	3.1[2]	4.5	
	propagation delay LE_{AB}, LE_{BA} to B_n, A_n	see Figs 7 and 10	2.7	–	4.3	5.9	ns
			3.0 to 3.6	1.5	3.5[2]	5.1	
	propagation delay CP_{AB}, CP_{BA} to B_n, A_n	see Figs 7 and 10	2.7	–	4.5	6.3	ns
			3.0 to 3.6	1.6	3.7[2]	5.5	
t_{PZH}/t_{PZL}	3-state output enable time $\overline{OE}_{AB}$, $\overline{OE}_{BA}$ to B_n, A_n	see Figs 8 and 10	2.7	–	3.9	6.7	ns
			3.0 to 3.6	1.6	3.1[2]	5.7	
t_{PHZ}/t_{PLZ}	3-state output disable time $\overline{OE}_{AB}$, $\overline{OE}_{BA}$ to B_n, A_n	see Figs 8 and 10	2.7	–	3.2	5.3	ns
			3.0 to 3.6	1.8	2.9[2]	4.8	
t_W	clock pulse width LE_{AB}, LE_{BA} to CP_{AB}, CP_{BA}	see Figs 7 and 10	2.7	3.3	0.7	–	ns
			3.0 to 3.6	3.3	0.9[2]	–	
	clock pulse width HIGH or LOW CP_{AB}, CP_{BA}	see Figs 7 and 10	2.7	3.3	1.2	–	ns
			3.0 to 3.6	3.3	0.9[2]	–	
t_{su}	set-up time A_n, B_n to CP_{AB}, CP_{BA}	see Figs 9 and 10	2.7	2.4	0.0	–	ns
			3.0 to 3.6	+2.1	−0.2[2]	–	
	set-up time A_n, B_n to LE_{AB}, LE_{BA}	see Figs 9 and 10	2.7	+1.2	−0.2	–	ns
			3.0 to 3.6	1.1	0.3[2]	–	
	set-up time $\overline{CE}_{AB}$, $\overline{CE}_{BA}$ to CP_{AB}, CP_{BA}		2.7	+2.0	−0.7	–	ns
			3.0 to 3.6	+1.7	−0.2[2]	–	
t_h	hold time A_n, B_n to CP_{AB}, CP_{BA}	see Figs 9 and 10	2.7	1.1	0.3	–	ns
			3.0 to 3.6	+1.0	−0.1[2]	–	
	hold time A_n, B_n to LE_{AB}, LE_{BA}	see Figs 9 and 10	2.7	1.6	0.1	–	ns
			3.0 to 3.6	1.4	0.1[2]	–	
	hold time $\overline{CE}_{AB}$, $\overline{CE}_{BA}$ to CP_{AB}, CP_{BA}		2.7	1.2	0.6	–	ns
			3.0 to 3.6	1.1	0.4[2]	–	
f_{max}	maximum clock pulse frequency	see Figs 7 and 10	2.7	150	190	–	MHz
			3.0 to 3.6	150	240[2]	–	

Notes

1. All typical values are measured at T_{amb} = 25 °C.

2. Typical values at V_{CC} = 3.3 V.

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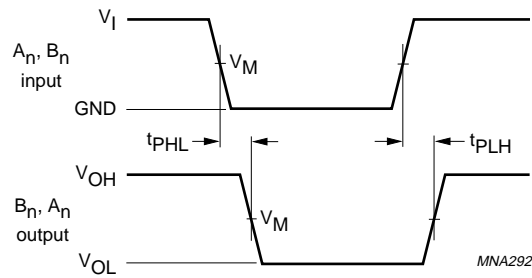termination resistor; 3-state

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AC WAVEFORMS

Fig.6 The input A_n, B_n to output B_n, A_n propagation delay times.

Notes: V_{CC} = 2.3 to 2.7 V

   $V_M = 0.5V_{CC}$;
   $V_X = V_{OL} + 150$ mV;
   $V_Y = V_{OH} - 150$ mV;
   $V_I = V_{CC}$;
   V_{OL} and V_{OH} are typical output voltage drop that occur with the output load.

Notes: V_{CC} = 3.0 to 3.6 V and V_{CC} = 2.7 V

   $V_M = 1.5$ V;
   $V_X = V_{OL} + 300$ mV;
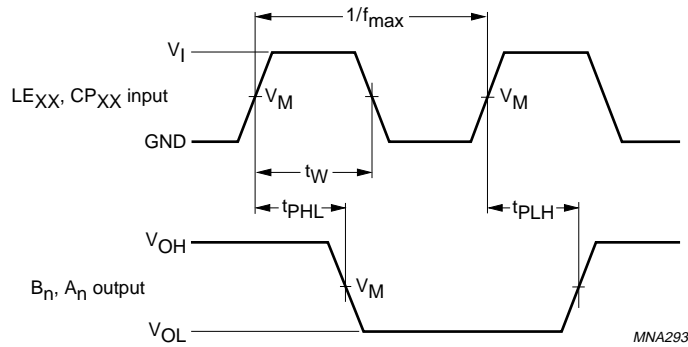 $V_Y = V_{OH} - 300$ mV;
   $V_I = 2.7$ V;
   V_{OL} and V_{OH} are typical output voltage drop that occur with the output load.
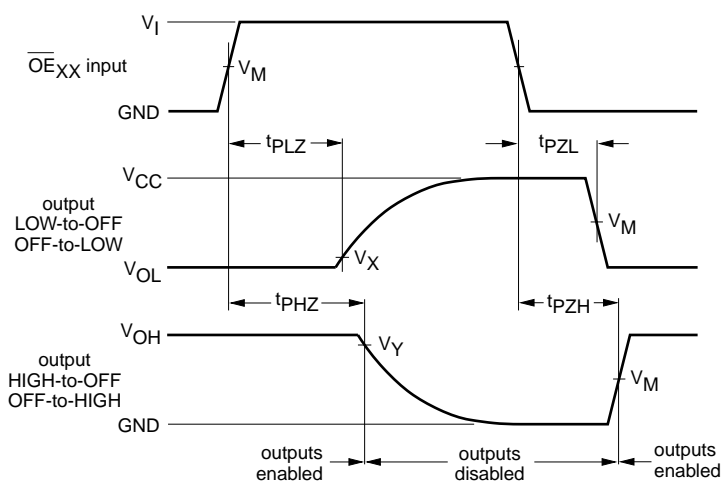
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Fig.7　Latch enable input LE_{AB}, LE_{BA} and clock input CP_{AB}, CP_{BA} to output B_n, A_n propagation delay times; pulse width and f_{max} of CP_{AB}, CP_{BA}.
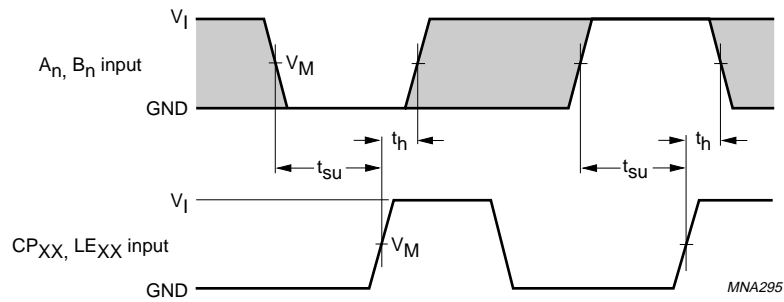

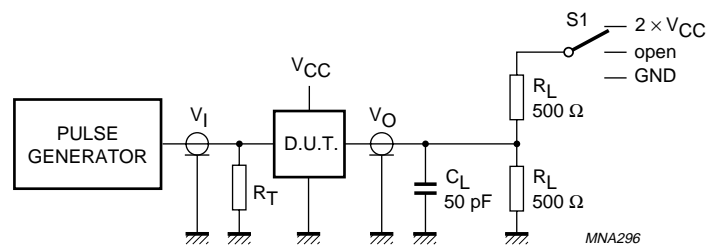Fig.8　3-state enable and disable times.

The shaded areas indicate when the input is permitted to change for predictable output performance.

Fig.9 Data set-up and hold times for A_n and B_n inputs to LE_{AB}, LE_{BA}, CP_{AB} or CP_{BA} inputs.

TEST	S1
t_{PLH}/t_{PHL}	open
t_{PLZ}/t_{PZL}	$2 \times V_{CC}$
t_{PHZ}/t_{PZH}	GND

V_{CC}	V_I
<2.7 V	V_{CC}
2.7 to 3.6 V	2.7 V

Definitions for test circuit.

C_L = load capacitance including jig and probe capacitance
(See Chapter "AC characteristics").

R_L = load resistance.

R_T = termination resistance should be equal to the output impedance Z_o of the pulse generator.

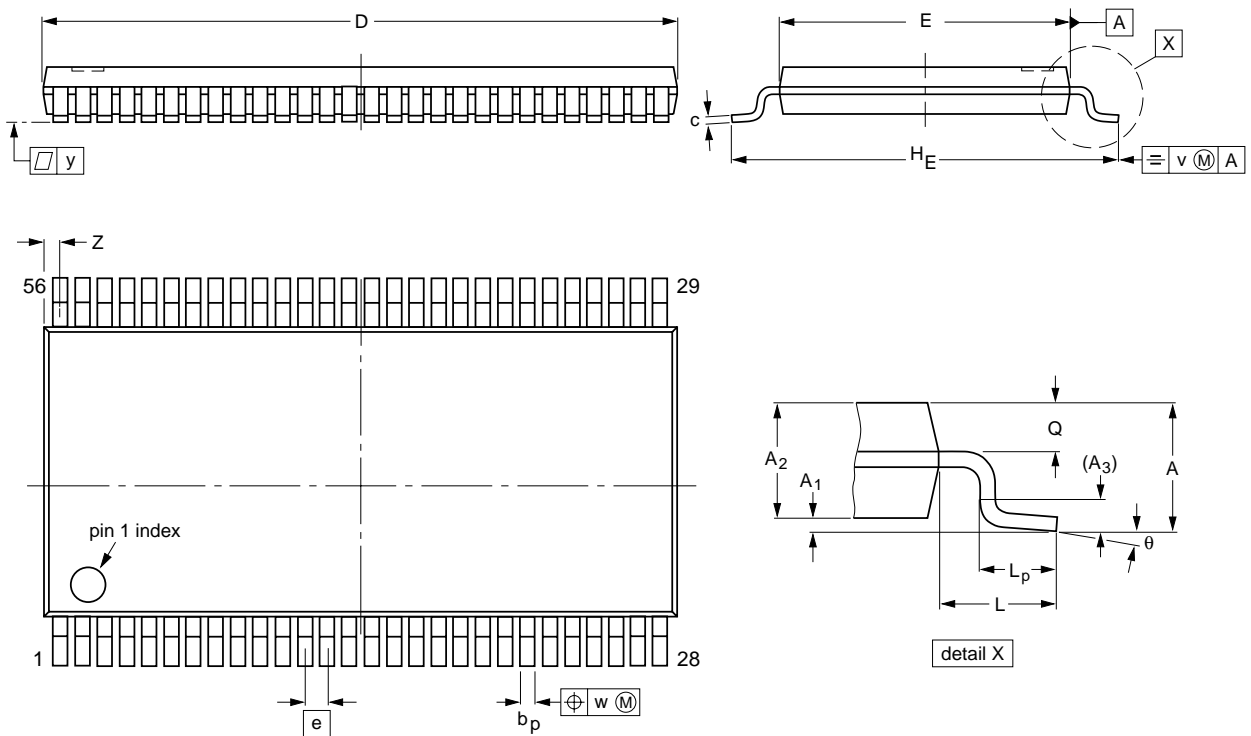Fig.10 Load circuitry for switching times.

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PACKAGE OUTLINE

TSSOP56: plastic thin shrink small outline package; 56 leads; body width 6.1 mm   **SOT364-1**

DIMENSIONS (mm are the original dimensions).

UNIT	A max.	A$_1$	A$_2$	A$_3$	b$_p$	c	D$^{(1)}$	E$^{(2)}$	e	H$_E$	L	L$_p$	Q	v	w	y	Z	θ
mm	1.2	0.15 0.05	1.05 0.85	0.25	0.28 0.17	0.2 0.1	14.1 13.9	6.2 6.0	0.5	8.3 7.9	1.0	0.8 0.4	0.50 0.35	0.25	0.08	0.1	0.5 0.1	8° 0°

Notes

1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.

2. Plastic interlead protrusions of 0.25 mm maximum per side are not included.

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	EIAJ			
SOT364-1		MO-153EE				~~93-02-03~~ 95-02-10

SOLDERING

Introduction to soldering surface mount packages

This text gives a very brief insight to a complex technology.
A more in-depth account of soldering ICs can be found in
our *"Data Handbook IC26; Integrated Circuit Packages"*
(document order number 9398 652 90011).

There is no soldering method that is ideal for all surface
mount IC packages. Wave soldering is not always suitable
for surface mount ICs, or for printed-circuit boards with
high population densities. In these situations reflow
soldering is often used.

Reflow soldering

Reflow soldering requires solder paste (a suspension of
fine solder particles, flux and binding agent) to be applied
to the printed-circuit board by screen printing, stencilling or
pressure-syringe dispensing before package placement.

Several methods exist for reflowing; for example,
infrared/convection heating in a conveyor type oven.
Throughput times (preheating, soldering and cooling) vary
between 100 and 200 seconds depending on heating
method.

Typical reflow peak temperatures range from
215 to 250 °C. The top-surface temperature of the
packages should preferable be kept below 230 °C.

Wave soldering

Conventional single wave soldering is not recommended
for surface mount devices (SMDs) or printed-circuit boards
with a high component density, as solder bridging and
non-wetting can present major problems.

To overcome these problems the double-wave soldering
method was specifically developed.

If wave soldering is used the following conditions must be
observed for optimal results:

- Use a double-wave soldering method comprising a
  turbulent wave with high upward pressure followed by a
  smooth laminar wave.

- For packages with leads on two sides and a pitch (e):
  - larger than or equal to 1.27 mm, the footprint
    longitudinal axis is **preferred** to be parallel to the
    transport direction of the printed-circuit board;
  - smaller than 1.27 mm, the footprint longitudinal axis
    must be parallel to the transport direction of the
    printed-circuit board.

  The footprint must incorporate solder thieves at the
  downstream end.

- For packages with leads on four sides, the footprint must
  be placed at a 45° angle to the transport direction of the
  printed-circuit board. The footprint must incorporate
  solder thieves downstream and at the side corners.

During placement and before soldering, the package must
be fixed with a droplet of adhesive. The adhesive can be
applied by screen printing, pin transfer or syringe
dispensing. The package can be soldered after the
adhesive is cured.

Typical dwell time is 4 seconds at 250 °C.
A mildly-activated flux will eliminate the need for removal
of corrosive residues in most applications.

Manual soldering

Fix the component by first soldering two
diagonally-opposite end leads. Use a low voltage (24 V or
less) soldering iron applied to the flat part of the lead.
Contact time must be limited to 10 seconds at up to
300 °C.

When using a dedicated tool, all other leads can be
soldered in one operation within 2 to 5 seconds between
270 and 320 °C.

Suitability of surface mount IC packages for wave and reflow soldering methods

PACKAGE	SOLDERING METHOD	
	WAVE	**REFLOW**[1]
BGA, SQFP	not suitable	suitable
HLQFP, HSQFP, HSOP, HTSSOP, SMS	not suitable[2]	suitable
PLCC[3], SO, SOJ	suitable	suitable
LQFP, QFP, TQFP	not recommended[3][4]	suitable
SSOP, TSSOP, VSO	not recommended[5]	suitable

Notes

1. All surface mount (SMD) packages are moisture sensitive. Depending upon the moisture content, the maximum temperature (with respect to time) and body size of the package, there is a risk that internal or external package cracks may occur due to vaporization of the moisture in them (the so called popcorn effect). For details, refer to the Drypack information in the *"Data Handbook IC26; Integrated Circuit Packages; Section: Packing Methods"*.

2. These packages are not suitable for wave soldering as a solder joint between the printed-circuit board and heatsink (at bottom version) can not be achieved, and as solder may stick to the heatsink (on top version).

3. If wave soldering is considered, then the package must be placed at a 45° angle to the solder wave direction. The package footprint must incorporate solder thieves downstream and at the side corners.

4. Wave soldering is only suitable for LQFP, TQFP and QFP packages with a pitch (e) equal to or larger than 0.8 mm; it is definitely not suitable for packages with a pitch (e) equal to or smaller than 0.65 mm.

5. Wave soldering is only suitable for SSOP and TSSOP packages with a pitch (e) equal to or larger than 0.65 mm; it is definitely not suitable for packages with a pitch (e) equal to or smaller than 0.5 mm.

DEFINITIONS

Data sheet status	
Objective specification	This data sheet contains target or goal specifications for product development.
Preliminary specification	This data sheet contains preliminary data; supplementary data may be published later.
Product specification	This data sheet contains final product specifications.
Limiting values	
Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.	
Application information	
Where application information is given, it is advisory and does not form part of the specification.	

LIFE SUPPORT APPLICATIONS

These products are not designed for use in life support appliances, devices, or systems where malfunction of these products can reasonably be expected to result in personal injury. Philips customers using or selling these products for use in such applications do so at their own risk and agree to fully indemnify Philips for any damages resulting from such improper use or sale.

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